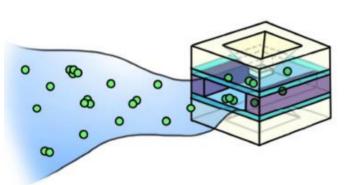


# Liquid Sample TEM

Characterize Nano-objects, Aggregates, and Agglomerates (NOAAs) in Product's Final Form or Relevant Media

## Our Technology (K-kit)

Specimen kit for observing the original morphology and physical state of nanomaterials in liquid sample by TEM

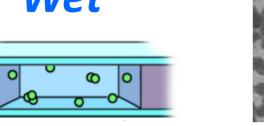


✓ US 7,807,979 B2 Oct. 5, 2010

filing number: 13/544,019

✓ *Anal. Chem.* 2012, 84, 6312-6316



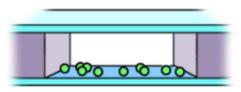


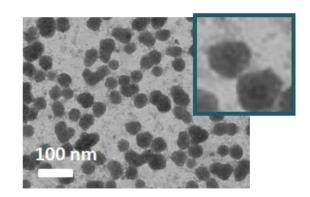
The loaded liquid sample is sealed and imaged by TEM in the native liquid environment.



√ US(SUPTO) filed on 2012/07/09 with







A proprietary sample preparation protocol preserves the original morphology and physical state with improved imaging resolution.

#### K-kit vs. Conventional

Physicochemical parameters	K-kit	Conventional
1. Composition		
2. Size		
3. Shape		
4. Size distribution		_
5. Aggregation/agglomeration state in relevant media		×
6. Particle Concentration	1	X
7. Liquid TEM observation	1	X
✓ Good		

Conventional K-kit (Aggregated by drying) (Original physical state)

\* NIST traceable polystyrene beads, Scale bar: 500 nm

## Definitive:

Direct observation in product's final form or relevant media, minimizing artifacts.

#### **Quantitative:**

Image-based statistical analysis of aggregation/agglomeration and particle concentration.

### Comprehensive:

All physicochemical characterization requirements can be addressed.

Contact window: Eva Chen \_ service@bioma-tek.com Lin-Ai Tai \_ project@bioma-tek.com



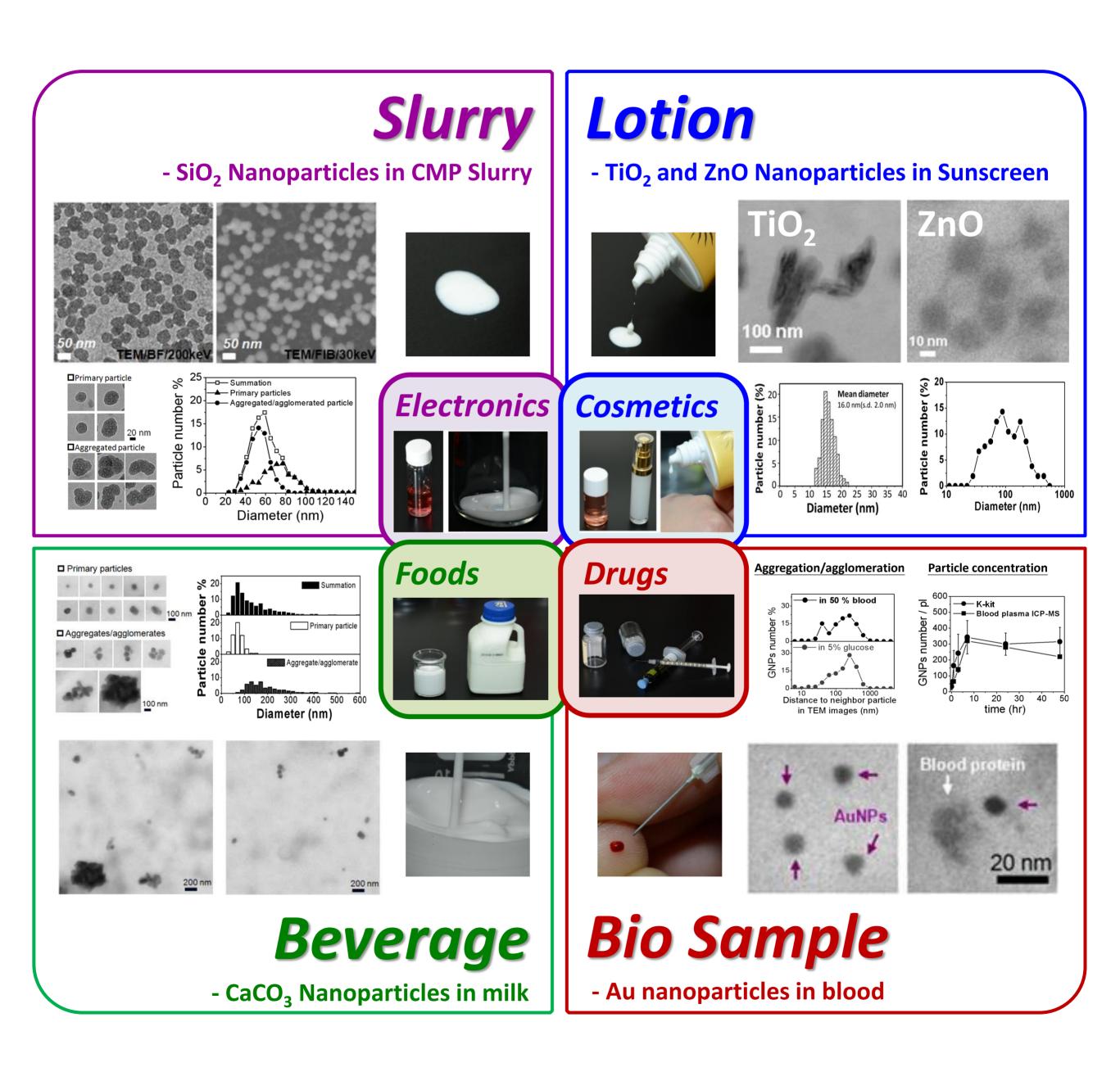
<sup>\*</sup> Undiluted CMP-slurry was directly loaded into K-kit to observe the primary and secondary abrasives by TEM.



# Nano in Products

Characterize Nano-objects, Aggregates, and Agglomerates (NOAAs) in Electronics, Cosmetics, Foods, and Drugs, etc...

# Goes with the Emerging Trend For Regulatory, Manufacturing, and R & D Purposes.



Contact window: Eva Chen \_ service@bioma-tek.com

Lin-Ai Tai project@bioma-tek.com